

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/091,946	LAUNAY ET AL.	
Examiner O'Neal R. Mistry		Art Unit 2625	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,415,163 A	05-1995	Harms et al.	600/410
*	B	US-6,112,109 A	08-2000	D'Urso, Paul Steven	600/407
*	C	US-6,195,450 B1	02-2001	Qian et al.	382/130
*	D	US-6,283,918 B1	09-2001	Kanda et al.	600/441
*	E	US-6,366,635 B1	04-2002	Op De Beek et al.	378/4
*	F	US-2002/0183607 A1	12-2002	Bauch et al.	600/407
*	G	US-6,541,024 B1	04-2003	Kadiyala et al.	424/426
*	H	US-6,714,668 B1	03-2004	Kerrien et al.	382/130
*	I	US-6,760,611 B1	07-2004	Watanabe, Shigeru	600/410
*	J	US-6,842,638 B1	01-2005	Suri et al.	600/425
*	K	US-6,839,457 B1	01-2005	Azuma et al.	382/131
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 02063439 A	03-1990	Japan	KEYES et al.	A61B 06/00
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.